
**User's
Manual**

**Model 701912/701913/701914
PBA1000/2500/1500
Active Probe**

Thank you for purchasing the PBA Series Active Probe.

This user's manual contains useful information about the functions and operating procedures of the PBA Series Active Probe and lists the handling precautions of the instrument. To ensure correct use, please read this manual thoroughly before beginning operation.

After reading this manual, keep it in a convenient location for quick reference in the event a question arises during operation.

Revisions

1st Edition:	June 2005
2nd Edition:	July 2005
3rd Edition:	July 2007
4th Edition:	April 2009
5th Edition:	March 2010

The following safety markings are used in this manual.



Improper handling or use can lead to injury to the user or damage to the instrument. This symbol appears on the instrument to indicate that the user must refer to the user's manual for special instructions. The same symbol appears in the corresponding place in the user's manual to identify those instructions. In the manual, the symbol is used in conjunction with the word "WARNING" or "CAUTION."

WARNING

Calls attention to actions or conditions that could cause serious injury or death to the user, and precautions that can be taken to prevent such occurrences.

CAUTION

Calls attentions to actions or conditions that could cause light injury to the user or damage to the instrument or user's data, and precautions that can be taken to prevent such occurrences.

Note

Calls attention to information that is important for proper operation of the instrument.

Checking the Contents of the Package

If any of the contents are incorrect, missing, or appear to be abnormal, please contact your Yokogawa dealer or representative.

Active Probe: 1

Various kinds of attachments (see page 2)

- Straight and angle pins: 8 each
- Spring type straight and angle pins: 8 each
- Microclips (red and black): 1 each
- Lead wires (red and black): 1 each
- L-pins: 2

User's manual (this manual): 1

Carrying case: 1

Optional Accessories (Sold Separately)

Standard accessory kit

701915

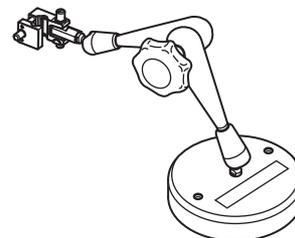
Composition

- Straight and angle pins: 20 each
- Spring-type straight and angle pins: 4 each
- Microclips (red and black): 1 each
- Lead wires (red and black): 1 each
- L-pins: 2
- case: 1

Probe stand

701919

External view



Safety Symbols and Precautions

To ensure safe and correct operation of the instrument, you must take the safety precautions given on the next page. The instrument may not function if used in a manner not described in this manual. Yokogawa bears no responsibility for, nor implies any warranty against damages occurring as a result of failure to take these precautions.

The following safety symbols and words are used in this manual.



Warning: Handle with care. Refer to the user's manual. This symbol appears on dangerous locations on the instrument which require special instructions for proper handling or use. The same symbol appears in the corresponding place in the manual to identify those instructions.)

See below for operating environmental limitations.

CAUTION

This product is a Class A (for industrial environments) product. Operation of this product in a residential area may cause radio interference in which case the user will be required to correct the interference.

Waste Electrical and Electronic Equipment (WEEE), Directive 2002/96/EC



(This directive is only valid in the EU).

This product complies with the WEEE Directive (2002/96/EC) marking requirement.

The following marking indicates that you must not discard this electrical/electronic product in domestic household waste.

Product Category

With reference to the equipment types in the WEEE directive Annex 1, this product is classified as a "Monitoring and Control instrumentation" product.

Do not dispose in domestic household waste. When disposing products in the EU, contact your local Yokogawa Europe B. V. office.

Safety Precautions

For safe use of the instrument, and for best results, please heed the following warnings and cautions.



WARNING

- Take care to avoid electric shock when connecting the probe to the item under test.
- Never disconnect the probe from the measuring instrument while the probe is connected to the circuit under test.
- Never use the probe with wet hands, or when the probe itself is wet. Electric shock can result.
- Before connecting the probe input terminal to the item under test, check that the measuring instrument is properly grounded, and that the probe output connector is connected to the input connector of the oscilloscope.
- Ground the measuring instrument.
Always connect the main instrument's protective grounding.
- Connect the probe's earth lead.
Connect the earth lead (ground potential) to ground.
- Maintain nondestructive input voltages.
Do not apply a voltage exceeding ± 25 V (DC+ACpeak) between input and ground.
- Do not use the probe in humid locations
To avoid electric shock, never use the probe in areas of high humidity.
- Do not use the probe near flammable gases.
To avoid injury and fire, do not use the probe near flammable or explosive gasses or vapors.
- Avoid exposed circuits.
To prevent injury, remove all jewelry such as rings and wristwatches. When the power is ON, do not touch any exposed contact points or components.



CAUTION

- The probe head has undergone a precision assembly process. Take sufficient care when handling the probe as sudden changes in ambient temperature and physical shocks can damage it.
 - Do not inadvertently twist or pull the cable. The wires inside the cable can break, causing malfunction.
 - Avoid vibration, shock, and static electricity during shipping and handling. Take extra care not to drop the probe.
 - Avoid storing or using the probe in direct sunlight, or in areas with high temperature, humidity, or condensation. Deformation and deterioration of insulation can occur resulting in failure to retain product specifications.
 - Inspect the probe before use to ensure that damage has not occurred during shipping and storing. If damage is found, contact your nearest Yokogawa dealer or sales representative.
 - This probe is not water or dust resistant. Do not use the probe in areas with a lot of dust, or near water.
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Product Overview

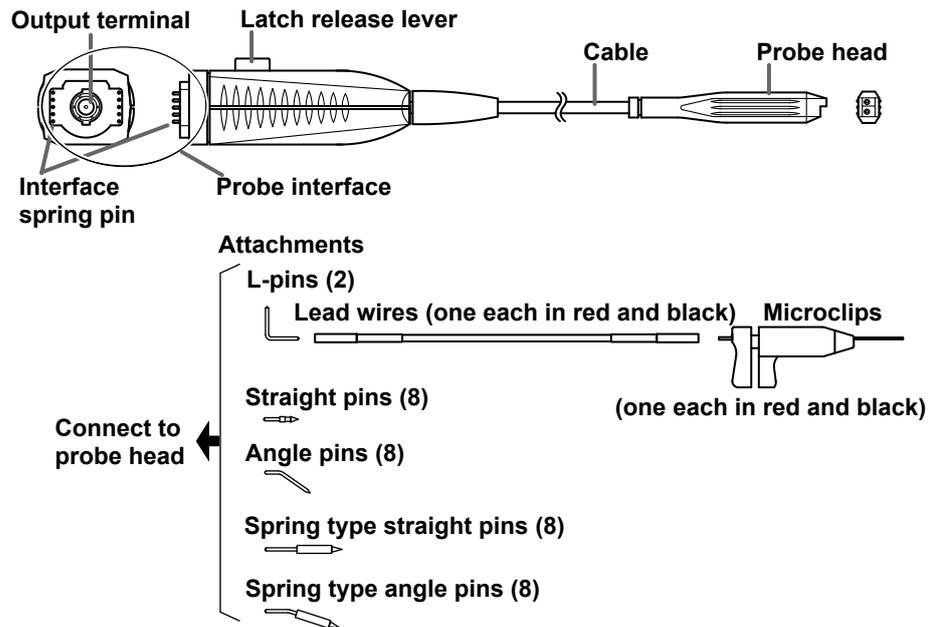
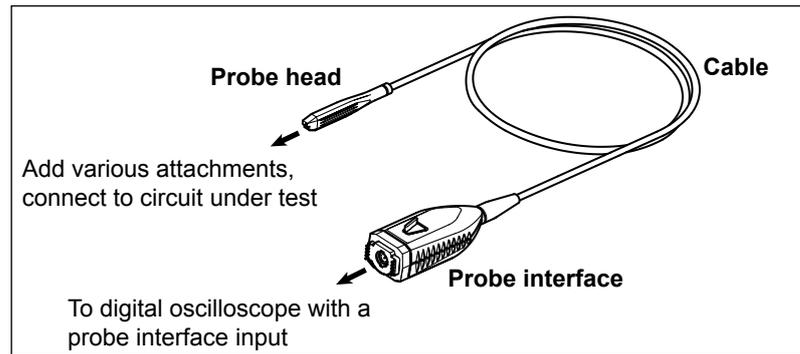
The PBA Active Probe Series are 2.5-GHz, 1.5-GHz, 1.0-GHz bandwidth single-ended active probes that are used in combination with a digital oscilloscope* that has a YOKOGAWA probe interface (hereafter referred as digital oscilloscope with a probe interface). To use the probe, you simply connect it to a BNC input terminal on a digital oscilloscope with a probe interface. By touching the probe tip to the circuit under test, you can view voltage waveforms.

* For information about digital oscilloscopes with a probe interface, contact your nearest YOKOGAWA dealer.

Features

- Wide frequency bandwidth (DC-2.5/1.5/1.0 GHz)
- Able to receive power from a digital oscilloscope with a probe interface
- Allows a digital oscilloscope with a probe interface to automatically detect the probe
- Connects to various attachments that are used to touch the circuit under test
- Compact and lightweight

Names of Parts



The quantity in parentheses () is the number of the various attachments that belong to a single probe.

Probe interface

The point of connection to the input of the digital oscilloscope.

Interface spring pin

When the probe output terminal is connected, it touches the pad on the interface board of the oscilloscope. The probe's power is supplied through this interface component. The interface also supplies the offset voltage, and allows automatic recognition of the probe.

Cable

Connects the probe interface and the probe head.

Probe head

Contacts the circuit under test through various attachments.

Latch release lever

A lever that releases the lock connecting the probe output terminal to the oscilloscope input.

Attachments

The probe's input terminals. An attachment is selected according to the circuit to be tested, and attached to the probe head.

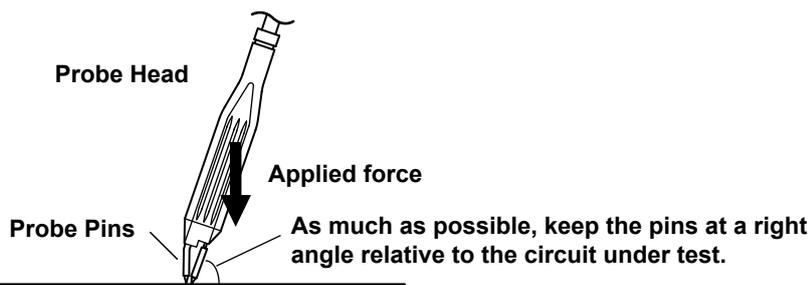
Output terminal

The output terminal is a BNC connector. It connects to the input of the oscilloscope (BNC connector).

Usage Precautions

CAUTION

- Use a soft cloth to wipe away dirt, and be careful not to damage the probe. Also, never dip the instrument in liquid, nor use any detergents or abrasives. Do not use any volatile solvents such as benzine.
- When touching the circuit under test with the probe pins, take care not to apply excessive force to the probe head. Damage can result if a force of 5 N or more is applied.



- Do not bring the probe near transformers, circuits with large currents, wireless devices, or other objects emitting large electric and/or magnetic fields. Inaccurate measurement may result.
- As much as possible, keep the probe pins vertical relative to the circuit under test.
- It is recommended to use the probe stand (model 701919). It can prevent excessive force from being applied to the probe head.

Operating Procedures

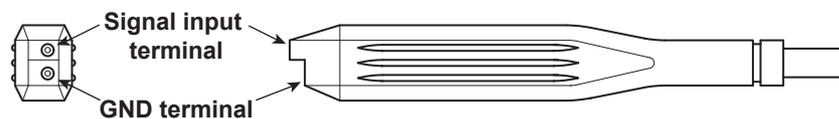
Preparing for Measurement

1. Set up the probe and the digital oscilloscope with a probe interface.
2. Insert the probe interface completely into the oscilloscope input, and confirm that the BNC connector and interface pin are securely fastened. You will hear the latch click when the connectors lock into place. When you connect the probe to a digital oscilloscope with a probe interface, the probe's attenuation ratio and input coupling are set automatically.
3. Attach any of the provided attachments to the probe head signal input terminals.

Handling the Attachments

You can change attachments according to the circuit to be tested.

As in the figure below, there is a hole for attaching the attachments to the tip of the probe head.

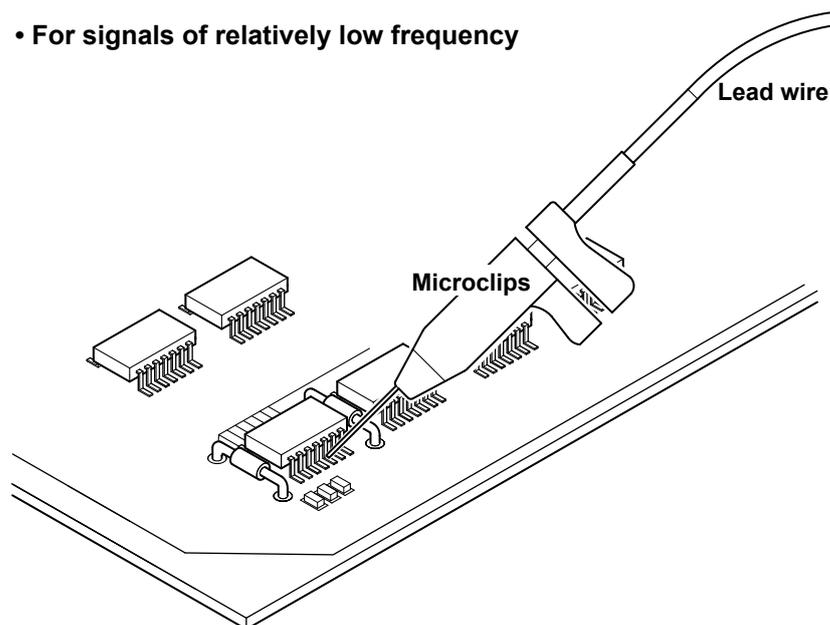


There are straight and angle pins. Select an attachment according to the circuit to be tested.

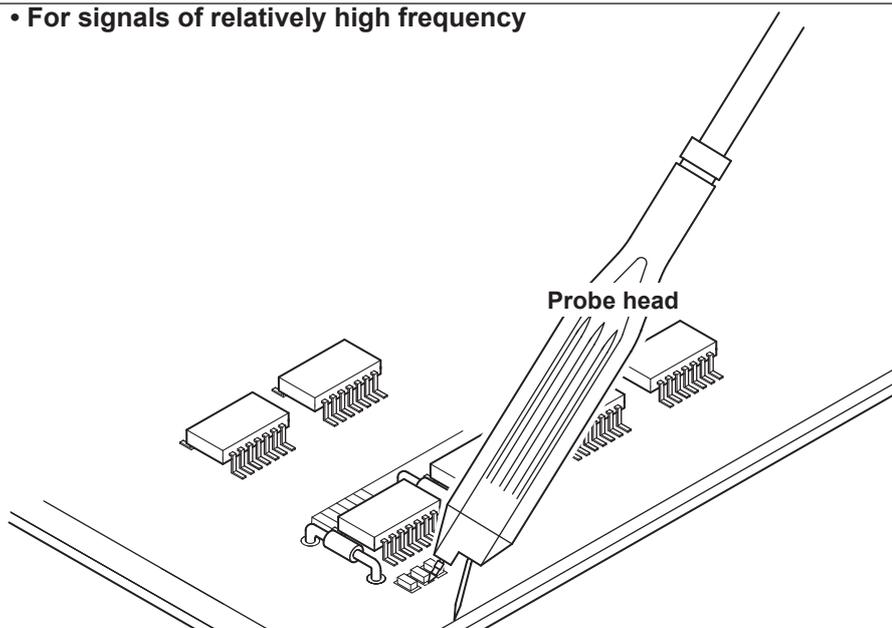
Since the impedance of the probe input is high, the inductance from the probe head to the circuit under test has a large effect on measured results of high frequency signal components. When measuring signals including frequencies of 100 MHz and higher in particular, we recommend that you use as short of an attachment as possible to connect the circuit under test to the probe head (both signal input terminal and ground terminal).

Example

- For signals of relatively low frequency



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- For signals of relatively high frequency



Select an attachment according to the circuit to be tested (straight pin, angle pin, spring type straight pin, spring type angle pin).

Note

The offset voltage drifts as a result of the ambient temperature. During continuous use, make sure the ambient temperature is stable.

Warm-up

Immediately after connecting the probe, the heat emitted by the probe itself causes the offset voltage to drift. Warm up the probe for at least 30 minutes after applying power to stabilize the probe.

Recommended Replacement Parts

The probe is covered by a one-year warranty (starting from the day of delivery). The warranty does not cover the following expendable parts (parts which wear out). Contact your nearest YOKOGAWA dealer to have parts replaced or repaired.

- Probe head part with two input sockets
- Probe interface

Note

- The service lives of the probe head part with two input sockets and probe interface vary depending on how the probe is used. Handle the probe with care.
 - If a problem such as a bad contact occurs while using the probe, consult your nearest YOKOGAWA dealer.
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Product Specifications

Electrical Specifications

(The electrical specifications are based on a standard operating conditions after a thirty-minute warm-up).

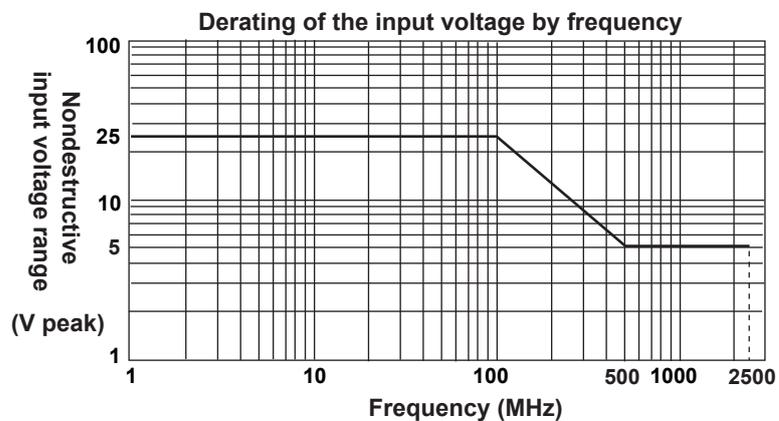
Frequency Bandwidth	
PBA2500	DC to 2.5 GHz (–3 dB or more)
PBA1500	DC to 1.5 GHz (–3 dB or more)
PBA1000	DC to 1.0 GHz (–3 dB or more)
Attenuation ratio and DC voltage accuracy ^{*1}	10:1, within ±2% (including oscilloscope error at a 50 Ω load)
Input capacitance	Approximately 0.9 pF (relative to ground, typical value ^{*4})
Input resistance:	Within ±2% of 100 kΩ
Output impedance	Approximately 50 Ω (typical value ^{*4})
Input dynamic range	±7 V
Offset voltage setting range	±10 V (set on the digital oscilloscope with a probe interface)
Operating input voltage range	±15 V (measurable voltage range when the offset voltage is applied)
Maximum non-destructive voltage ^{*2}	±25 V (DC+ACpeak)
Rise time	
PBA2500	140 ps or less (not including characteristics of the oscilloscope, typical value ^{*4})
PBA1500	233 ps or less (not including characteristics of the oscilloscope, typical value ^{*4})
PBA1000	350 ps or less (not including characteristics of the oscilloscope, typical value ^{*4})
Residual noise	300 μVrms or less (at the probe output within the bandwidth, typical value ^{*4})
Residual offset ^{*3}	Within ±2 mV(at the probe output)

*1 Excluding residual offset voltage

*2 Nondestructive maximum input voltage This is not the probe's dynamic range.

*3 When tip is shorted or when inputting 0 V

*4 Typical value represents a typical or average value. It is not strictly guaranteed.



General Specifications(Common to the PBA Series)

Power range	Standard power supply voltage of ± 5 V, within $\pm 5\%$	
Interface	(The probe is supplied power from a dedicated terminal. Connect the probe to a digital oscilloscope with a compatible terminal)	
Storage altitude	3,000 m or less	
Operating altitude	2,000 m or less	
Standard operating environment	Temperature range	$23^{\circ}\text{C} \pm 5^{\circ}\text{C}$
	Humidity range ^{*5}	$55\% \pm 10\% \text{RH}$
Operating environment	Temperature range	5°C to 40°C
	Humidity range ^{*5}	20 to 80%RH
Storage environment	Temperature range	-20 to 60°C
	Humidity range ^{*5}	20 to 80%RH
Calibration cycle	1 year	
Warm-up time	30 minutes or more	
Total length	Approximately 1.2 m.	
Weight	Approximately 80 g.	

Standards Compliance

EMC	Emission	Complying standards	EN61326-1 Class A EN55011 Class A, Group1 C-tick EN55011 Class A, Group1
	Immunity	Complying standards	EN61326-1 Table 2 (for use in industrial locations)
		Influence in the immunity testing environment	$ \text{noise increase} \leq 2 \text{ V}^6$

*5 No condensation

*6 Test conditions

Frequency bandwidth limit of 20 MHz, using a DL9000 series digital oscilloscope set for an input impedance of 50Ω , and probe tip terminated at 50Ω .

Appendix (High Speed Waveform Measurement and Probing)

The speed of devices and electronic circuits incorporated into a variety of instruments, including digital home electronics, is increasing and the oscilloscopes and probes used to observe their signal waveforms are also faster and have wider bandwidths.

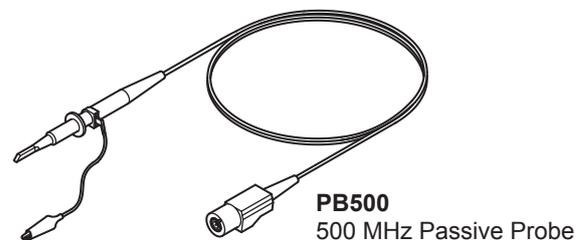
When the speed of the measured signal increases, there are cases when correct measurements cannot be taken due to problems that have never occurred before, especially in probing. In this article I offer some hints regarding the accurate probing of high speed signals.

Types of Voltage Probe

A Voltage probes is a type of voltage sensor. The ideal probe should be selected according to the signal's voltage, output impedance, frequency components, and other factors. Individual probes have their own particular pros and cons, and since the input impedance (resistance and capacitance) and frequency can differ greatly depending on the type of probe, it is essential to understand the characteristics of the available probes in order to obtain highly reliable measurements. Below are three examples of probes generally used for measurements on high frequency circuits.

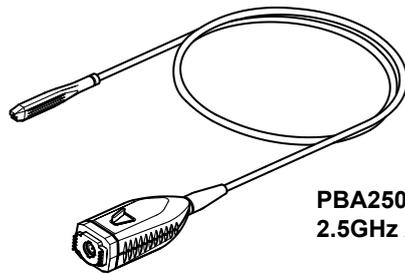
Passive Probes

Passive probes with a 10:1 attenuation ratio are the most widely used due to their low cost, ruggedness, high withstand voltage, and high input impedance at DC and low frequencies. Yokogawa's standard 10:1 passive probes are easy-to-use for general applications. They have an input impedance of 10 M Ω , an input capacitance of approximately 12.5 pF and a withstand voltage of 600 V. However the 12.5 pF input capacitance might cause problems when high frequencies are measured.



Active Probes / FET Probes

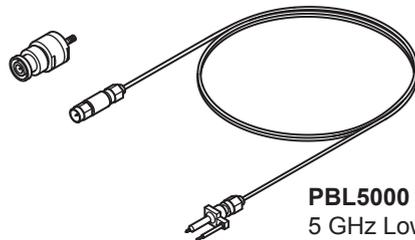
Active and FET probes are those most often used to measure high frequency signals. Unlike passive probes, an impedance converting buffer amplifier is situated near the tip of the probe which enables them to handle higher frequencies with around 1 pF input capacitance. They require a power supply and must be handled with more care than a passive probe since the with-stand voltage is lower. They are very effective in terms of reliability and their ability to reproduce high frequency signal waveforms.



PBA2500
2.5GHz Active Probe

Low Capacitance Probes (Resistance)

These probes are not so well known, but they have been used with measuring instruments having 50 Ω inputs for a relatively long time. The probe head has a special built-in 450 Ω or 950 Ω resistor, designed for high frequency, and uses a 50 Ω coaxial cable. The input capacitance is extremely small. As the input resistance is 500 Ω or 1 k Ω it can have an affect on the DC bias or output amplitude if the impedance of the signal source being measured is high. However, this probe is ideal for high quality measurement of clock edges or other high speed digital signal waveforms as the input capacitance is half, or even a small fraction, of that of the active probe.



PBL5000
5 GHz Low Capacitance Probe

Problems with Probing High Speed Signals

The Loading Effect

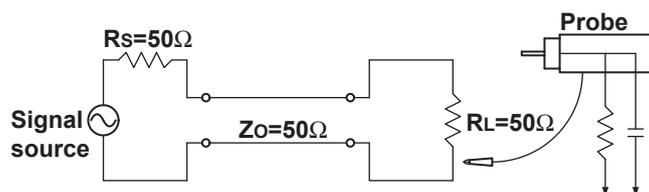
When a probe is connected to the circuit under test, the input impedance of the probe itself has certain effects on the circuit. This is called the loading effect. For example, when measuring a feedback circuit, the phase of the circuit changes due to the impedance of the connected probe, thus changing the operation of the circuit. For oscillating circuits, the frequency of oscillation can change or the oscillation can stop altogether. Special care must be taken when selecting a probe for measuring circuits that are sensitive to capacitance.

Observational Bandwidth Limits due to Probe Input Capacitance

There can be cases where there are notable low pass filter effects related to the signal source impedance and the probe's load capacitance particularly when observing frequency components of 100 MHz or more.

Let us take an example of a $50\ \Omega$ circuit (see below). In this example, the equivalent signal source impedance can be seen as $25\ \Omega$ ($2 \times 50\ \Omega$ in parallel) when observing the signal waveform at the load (terminal), and the cutoff frequency at the probe's input point is $f_c = 1/2\pi RC$ if the probe input capacitance is added. When using a passive probe with an input capacitance of $12.5\ \text{pF}$, f_c equals $509\ \text{MHz}$, but when a $0.9\ \text{pF}$ input capacitance active probe is used, f_c equals $7\ \text{GHz}$.

It is preferable to use an active or FET probe with a smaller input capacitance because even more pronounced loading effects emerge when measuring a circuit with a high output impedance.



Resonance due to Inductance

Pins or wires of one sort or another are used to connect the probe to the circuit under test. Inductance occurs when these pins or wires reach certain lengths, which results in resonance with the probe's input capacitance. This will not obscure observation of the waveform if these resonant frequencies are outside of the oscilloscope's frequency bandwidth, but overshooting or ringing, which was not originally present, is introduced into the signal waveform being observed when the inductance or capacitance is large. The resonant frequency is surprisingly low when the resonant frequencies of three different types of probes are compared as in following table with a given connected inductance of $10\ \text{nH}$ (a length of up to 1-2 cm). The user must be aware that effects of this inductance can be found not only on the probe input, but also in the ground connection.

	PB500 Passive Probe	PBA Series Active Probe	PBL5000 Low Capacitance Probe
Input Impedance	Approx $12.5\ \text{pF}$	Approx $0.9\ \text{pF}$	Approx $0.25\ \text{pF}$ or $0.4\ \text{pF}$
Resonant Frequency (When $L = 10\ \text{nH}$)	$450\ \text{MHz}$	$1.68\ \text{GHz}$	$3.18\ \text{GHz}$ or $2.52\ \text{GHz}$

Changes in Cable Characteristics

A coaxial cable is used to transfer signals from the probe tip to the oscilloscope. Cables that can offer the right balance of both flexibility and high frequency performance are selected after considering the ways in which the cables will actually be handled. Even so, if a cable is bent sharply, the dielectric can break, altering the characteristic impedance and subsequently weakening the cable's throughput and reflectivity. This in turn will affect the high frequency components of the observed waveform. This is one of the causes of poor repeatability in the observation of high frequency waveforms and the repeatability can be increased by bending the cables as little as possible. When bending is necessary, please do so in a uniform manner.

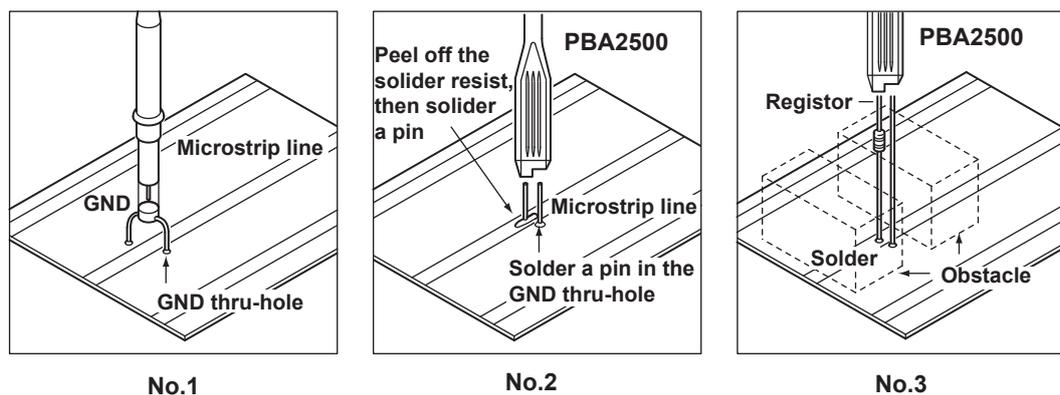
Getting the Best Performance Out of Your Probe

When using probes, inductance-based resonance is the biggest problem during waveform measurement and it is most important to suppress it. Make the probe's input pins and ground lead as short as possible when the goal is to easily check signals (browsing). When highly reliable waveform observation is called for, prepare a thru-hole PCB for connecting the probe and directly connect the probe's signal input pins onto the PCB track or to another fitting (No. 1 and No. 2). Connect the probe to a prepared copper wire or plate that is as thick as possible to reduce inductance in the ground.

If it is simply not possible to connect a short wire, you can insert a 50-100 Ω resistor to dampen the resonance (No. 3). In this case, the measurable frequency bandwidth is reduced by the resistance, but you can approximate the original waveform more closely by suppressing the resonance effects of overshooting and ringing.

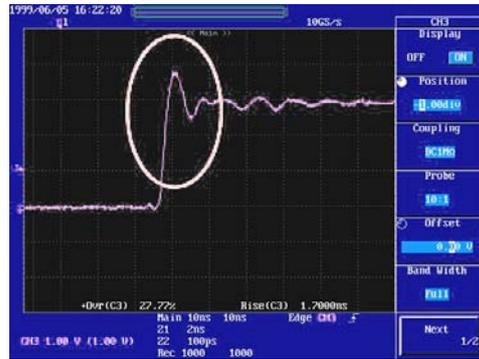
Also, try securing the cable to the workbench with tape so that the bends in the cable do not change (See the next page) since high frequency signal components are, as stated above, affected by cable bending. This may improve the repeatability of the observed waveform.

Ringings Comparison

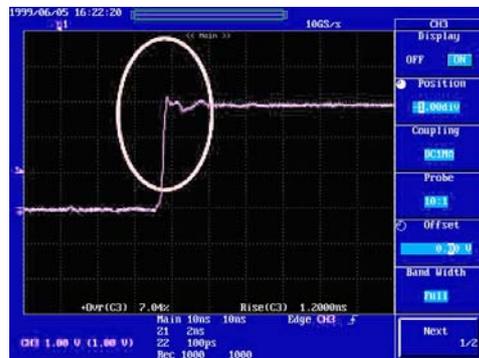


Ringing Comparison

When inductance is large and ringing can be seen.



When inductance is small and ringing is suppressed.



Probe Cable Bending

